

Nanoscale Lithography

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CMU

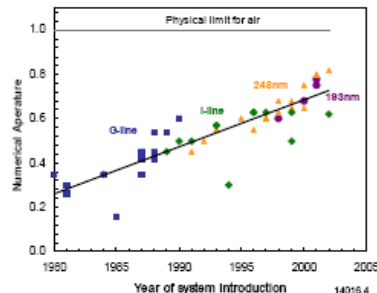
Pushing The Limits of Photolithography

- Reduce wavelength (λ)
- Use Reducing Lens
- Increase Numerical Aperture (NA) of Lens
 - E.g., Immersion optics
- Hacks (k_1)
 - PSM, OPC, RET, off-axis illumination
- Rayleigh eqn: min-feature-size = $k_1 \lambda / \text{NA}$

Trends in λ , NA, k_1

Table 1. Minimum linewidth and exposure wavelength versus year

Year	Linewidth (nm)	Wavelength (nm)
1986	1,300	435
1988	800	435/365
1991	500	365
1994	350	365/248
1997	250	248
1999	180	248
2001	130	248
2003	90	248/193
2005 (first)	65	193
2007 (first)	45	193



ICKnowledge.com

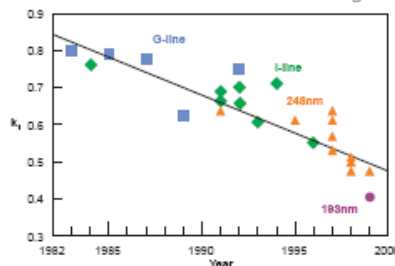


Figure 2. K_1 trend [5].

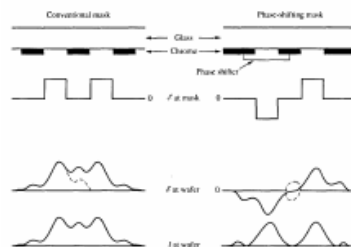
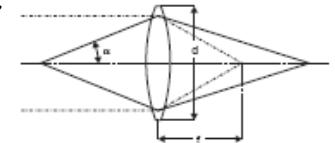


Figure 3. Numerical aperture.

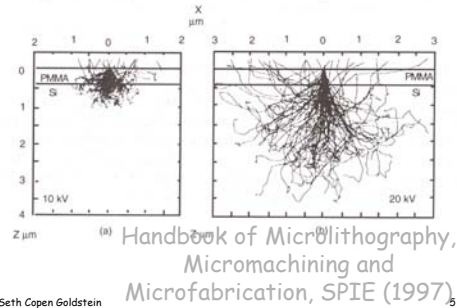
- $\text{NA} = n \sin \alpha = d / (2f)$
 - n is index of refraction of medium
 - α is angle of acceptance
- Air, $n=1$
- Water, $n \approx 1.47$
- Result $\rightarrow$ improve min linewidth 30%!



CUHG, Chap 5.

E-Beam? FIB?

- Use high-energy electrons to alter/ablate a resist
- Issues:
 - Secondary electrons
 - Scattering in resist (or off substrate)
 - Serial process
 - alignment

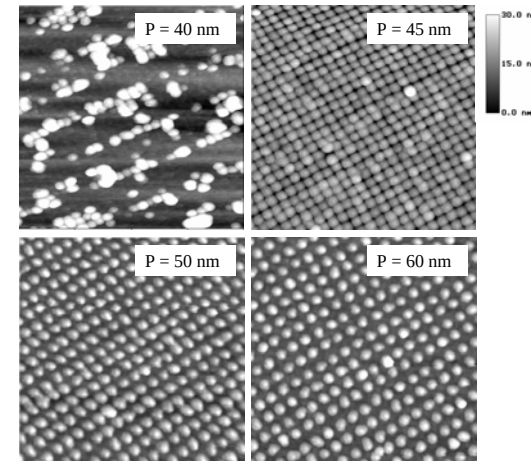


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Example of E-beam patterning



UofA, Nanolithography

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Microelectronics isn't everything

- Reactive organics
- 3-D structures

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Today

- Soft Lithography/Nanoimprint
- Scanning Probe Lithography
- Edge Lithography
- Top-down fabrication to create nanoscale features using a physical mold or tip for patterning.

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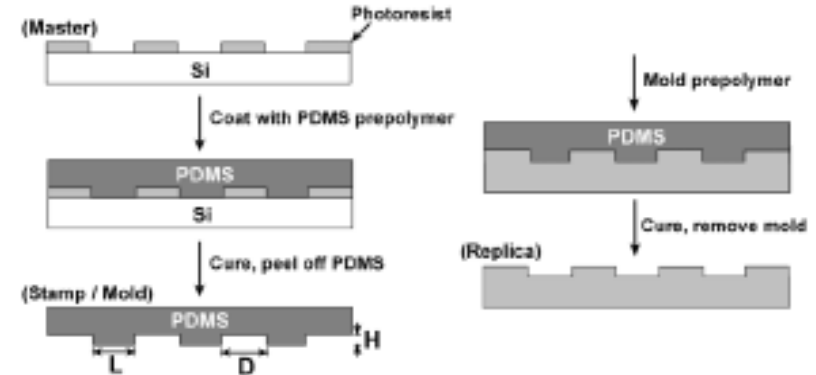
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Soft Litho

- Replica Molding
transfer features from master to replica by curing a liquid
- Embossing
transfer of features from master to replica by pressing
- Microcontact Printing
transfer of material on master to replica by stamping

Basic Example



Unless otherwise notes, pictures from Unconventional Nanofabrication, Gates et al, ARMR 2004

The Mold

- Some important features:
 - Master should be reusable many times (self-cleaning)
 - Create fine features
 - Flexible
 - Stable
 - Optically transparant (for some processes)
 - Thermally stable
 - Inert
 - Low adhesive forces

Causes of Distortion

- Differences in thermal expansion between master and replica
- Shrinkage during curing
 - x-linking
 - Evaporation
- Adhesion at time of separation
- Collapse at separation

PDMS

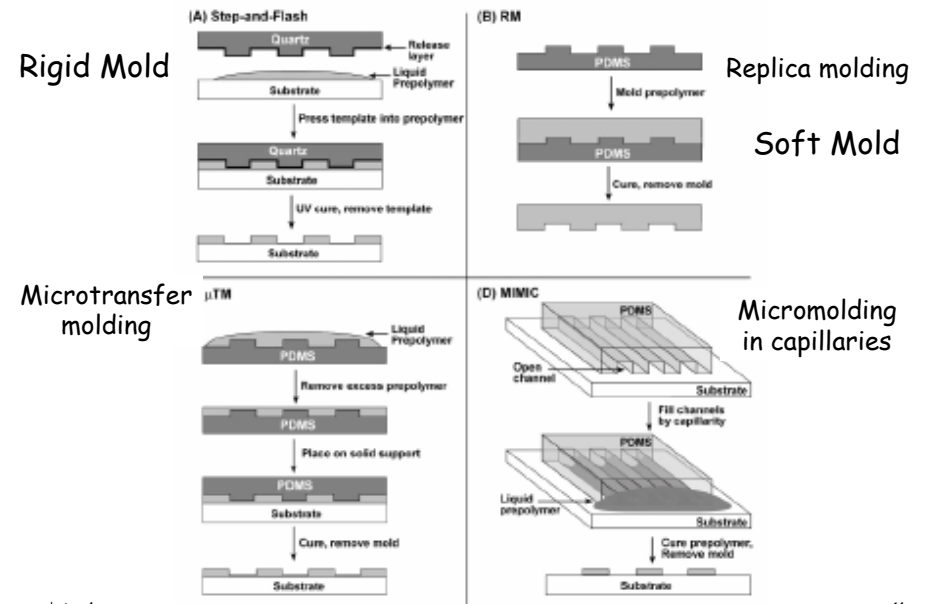
- Poly(dimethylsiloxane) silicone rubber
- Very common mold material. A resist
- Inert to materials being patterned
- Low surface energy (eases release)
- Optically transparent
- Thermally stable
- Tough
- Flexible
- No solvent evaporation
- Low-temp curing

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Replica Molding



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Rigid Molds

- E.g., Step-and-flash
 - Add Liquid pre-polymer
 - Press master
 - Expose to UV
- 30nm features
- High-aspect ratio of lines
- Rapid cycle-time
- Alignment of master and replica
- Replica needs to be planar
- Multi-layer structures hard

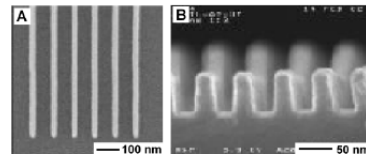


Figure 3 (a) Scanning electron microscopy (SEM) image of 30-nm wide lines molded into UV-cured 1,3-bis(methacryloxypropyl)tetramethyldisiloxane as patterned by step-and-flash lithography (22) (reprinted with permission, © SPIE 2002). The image in (b) shows a cross-section of these lines.

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Soft Molds

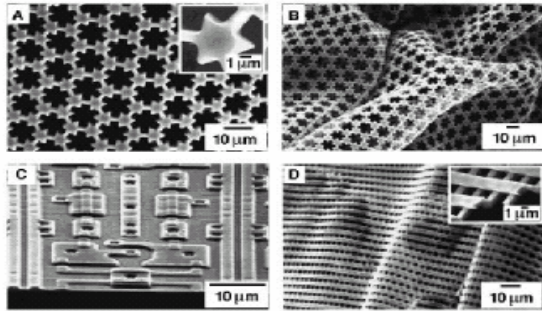
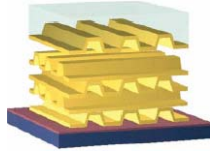
- Can pattern non-planar and soft surfaces
- Photo- or thermal curing
- large range of materials can be molded
- Potential for large surface area molds

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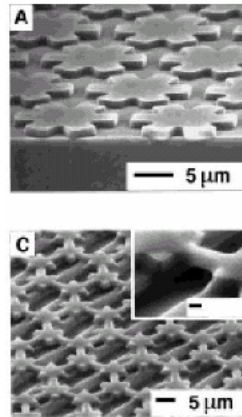
Examples



MIMIC

E. Kim *et al*, Nature, 376, 581 (1995)

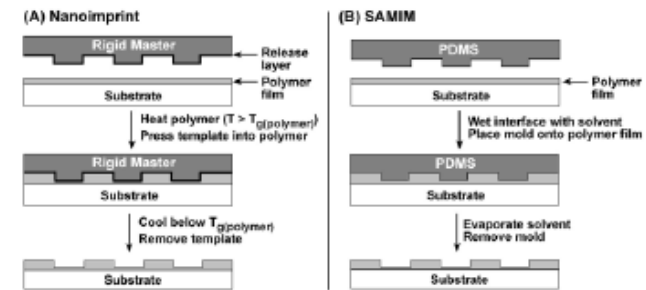
Microcontact transfer



S. Jeon *et al.*, Advanced Materials, 16, 1369 (2004)

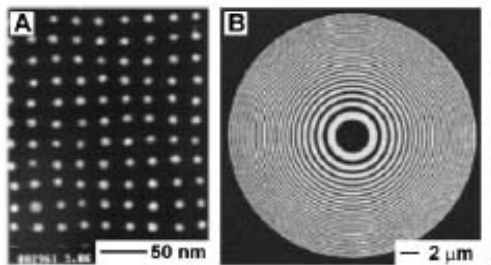
Embossing

- Press mold into replica to create structures
- Generally, thermally assisted
- Used at microlevel commercially (e.g., DVD)
- Nanoscale features <50nm



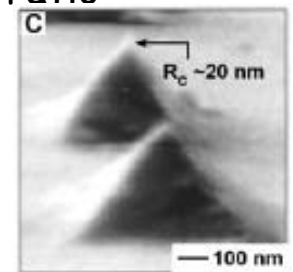
Embossing - rigid molds

- Nanoimprint lithography (NIL)
- Press mold, heat polymer, cool, release
- Features 10nm, high-aspect ratio
- Long exposure times (5 - 10 min)
- Hard for large areas



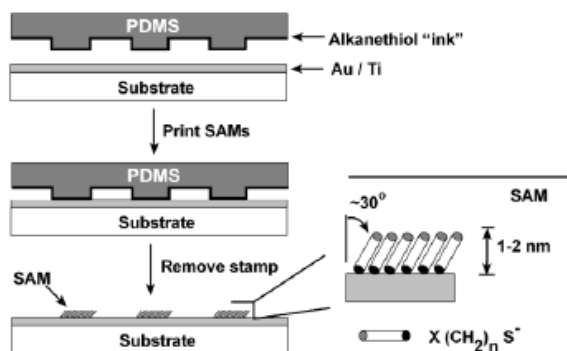
Embossing - soft molds

- SAMIM, solvent-assisted micromolding
- Reduces pressure and temp needed due to solvent
- Eliminates trapped air pockets
- 60nm features, low aspect ratio
- Non-planar surfaces
- Large areas



Mircococontact Printing

- Transfers "ink" from master to replica
- Ink is a self-assembled monolayer (SAM)
- 50nm features



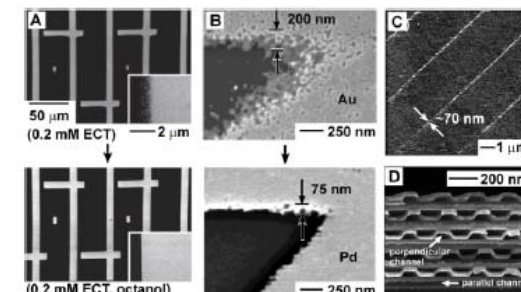
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Microcontact printing

- Planar and curved surfaces
- Many different kinds of "ink"
- Min resolution affected by diffusion of molecules
- Organics supported
- Multilayers ok



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Soft Lithography

- Pluses and minues?

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Soft Lithography

- Advantages
 - Avoids complexity of photolithography
 - Inexpensive
 - Some 3-D possible
 - Organics can be patterned
- Disadvantages
 - Heat, pressure can be harmful
 - Still experimental (low yield)
 - Limits due to lift-off?

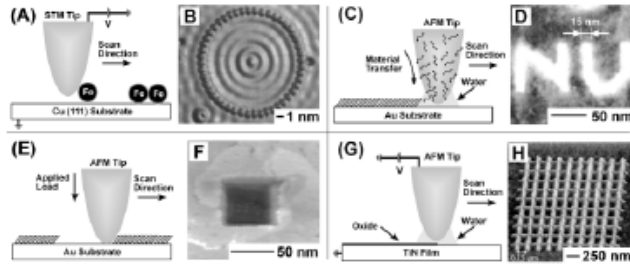
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SPL

- Scanning Probe Lithography
 - STM tip
 - AFM tip
 - Dip-Pen lithography



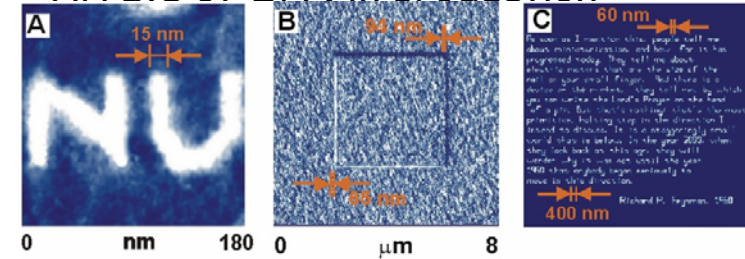
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DPN

- AFM tip is "inked" with material to be deposited
- Material is adsorbed on target
- <15nm features
- Arrays of DPN in production



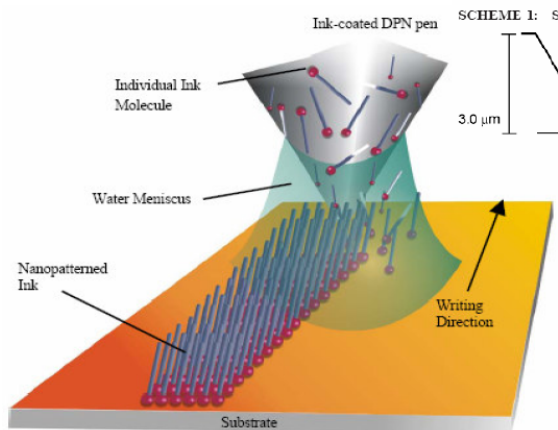
<http://www.chem.northwestern.edu/~mkngrp/dpn.htm>

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Schematic of DPN



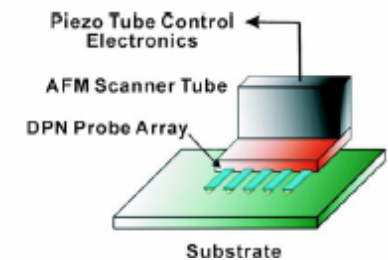
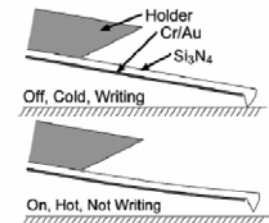
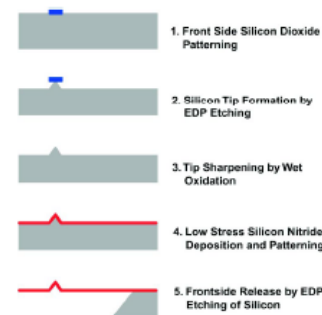
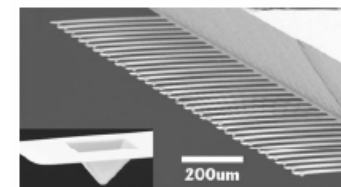
www.nanoink.net

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Arrays



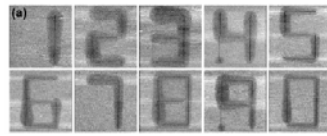
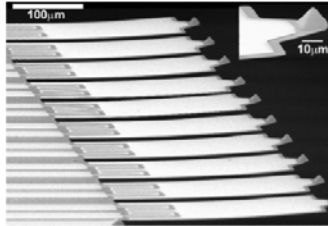
Nanotechnology 13 (2002) 212-217

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Array Example

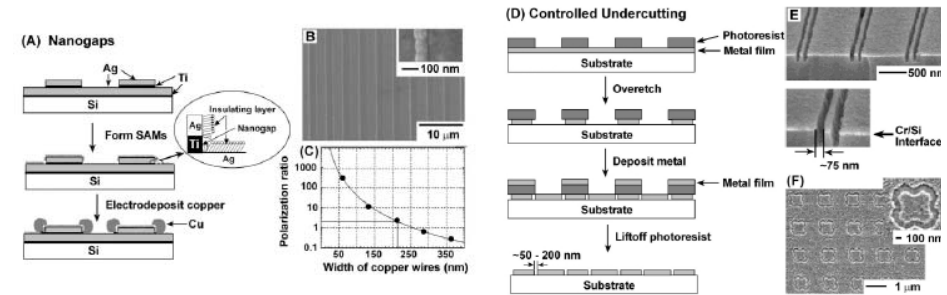


Ten different DPN patterns written simultaneously by the ten probes of a TA-DPN array. Deposited ODT shows up dark in these 8 μm x 8 μm LFM scans.

JOURNAL OF MICROELECTROMECHANICAL SYSTEMS, VOL. 13, NO. 4, P 594, 2004

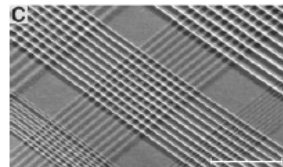
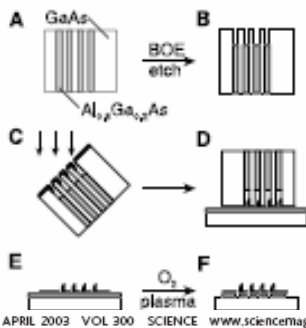
Edge Litho

- Using Edges produced in another process to double pitch
- Using Edges in material as a stamp (more like NIL)



SNAP

- Create a stamp by using the cleaved edges of a layered material formed through MBE
- Then, e.g., transfer SAMS



8nm Pt nanowire array

4 APRIL 2003 VOL 300 SCIENCE www.sciencemag.org

SNAP V. Other

- EBL can make 20nm patterns, but ...
 - Lift-off for small wires at low pitch or high-pitch limits final result
 - Result is min pitch much higher (~60nm?)
 - Pitch is everything?
 - EBL serial
- Soft-litho master - how created?

Summary

- Top-down litho can get to fine features and fine pitches.
- What about complexity of the pattern?
- Keep in mind:
 - Master manufacturing
 - Alignment, imprinting, releasing
 - resist/solvent/material chemistry